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TOSHIBA Field Effect Transistor Silicon N Channel MOS Type (π-MOSV)

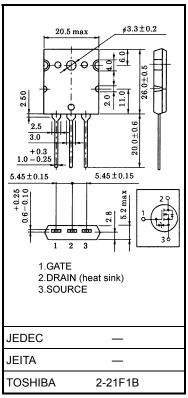
2SK3131

Chopper Regulator DC–DC Converter and Motor Drive Applications

- Fast reverse recovery time $: t_{rr} = 105 \text{ ns (typ.)}$
- Built-in high-speed free-wheeling diode
- Low drain-source ON resistance $: RDS(ON) = 0.085 \Omega$ (typ.)
- High forward transfer admittance $|Y_{fs}| = 35 \text{ S} (typ.)$
- Low leakage current $: IDSS = 100 \ \mu A \ (max) \ (VDS = 500 \ V)$
- Enhancement mode $: V_{th} = 2.4 \sim 3.4 \text{ V} (V_{DS} = 10 \text{ V}, \text{Ip} = 1 \text{ mA})$

Maximum Ratings (Ta = 25°C)

Characteris	stics	Symbol	Rating	Unit	
Drain-source voltage		V _{DSS}	500	V	
Drain-gate voltage (R	_{GS} = 20 kΩ)	V _{DGR}	500	V	
Gate-source voltage		V _{GSS}	±30	V	
DC Drain current	DC (Note 1)	I _D	50	А	
	Pulse (Note 1)	I _{DP}	200	А	
Drain power dissipation	n (Tc = 25°C)	PD	250	W	
Single pulse avalanche	e energy (Note 2)	E _{AS}	525	mJ	
Avalanche current		I _{AR}	50	А	
Repetitive avalanche e	nergy (Note 3)	E _{AR}	25	mJ	
Channel temperature		T _{ch}	150	°C	
Storage temperature ra	ange	T _{stg}	-55~150	°C	



Weight: 9.75 g (typ.)

Thermal Characteristics

Characteristics	Symbol	Max	Unit
Thermal resistance, channel to case	R _{th (ch-c)}	0.5	°C / W
Thermal resistance, channel to ambient	R _{th (ch−a)}	35.7	°C / W

Note 1: Ensure that the channel temperature does not exceed 150°C.

Note 2: V_DD = 90 V, T_ch = 25°C (initial), L = 357 μ H, R_G = 25 Ω , I_{AR} = 50 A

Note 3: Repetitive rating: pulse width limited by maximum channel temperature.

This transistor is an electrostatic-sensitive device. Please handle with caution. Unit: mm

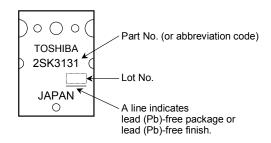
Electrical Characteristics (Ta = 25°C)

Charao	cteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Gate leakage current		I _{GSS}	V _{GS} = ±25 V, V _{DS} = 0 V	_	—	±10	μA
Gate-source bro	eakdown voltage	V (BR) GSS	I _G = ±100 μA, V _{DS} = 0 V	±30	_		V
Drain cut-off cu	rrent	I _{DSS}	V _{DS} = 500 V, V _{GS} = 0 V		_	100	μA
Drain-source br	eakdown voltage	V (BR) DSS	I _D = 10 mA, V _{GS} = 0 V	500	_		V
Gate threshold v	voltage	V _{th}	V _{DS} = 10 V, I _D = 1 mA	2.4	_	3.4	V
Drain-source O	N resistance	R _{DS (ON)}	V _{GS} = 10 V, I _D = 25 A		0.085	0.11	Ω
Forward transfe	r admittance	Y _{fs}	V _{DS} = 10 V, I _D = 25 A	15	35		S
Input capacitance	e	Ciss			11000		pF
Reverse transfer capacitance		C _{rss}	V _{DS} = 10 V, V _{GS} = 0 V, f = 1 MHz		2100		
Output capacitance		C _{oss}			4200		
Switching time	Rise time	tr	$V_{GS} \stackrel{10V}{}_{0V} \int I_{D} = 25A$ $V_{GS} \stackrel{10V}{}_{0V} \int I_{D} = 25A$ $V_{OUT} \stackrel{V}{}_{OUT} \stackrel{V}{}_{OUT} \stackrel{V}{}_{OUT} = 8\Omega$ $V_{DD} = 200V$	_	105	_	- ns
	Turn-on time	t _{on}		_	160	_	
	Fall time	t _f		_	65	_	
	Turn-off time	t _{off}	Duty $\leq 1\%$, t _w =10µs	_	245		
Total gate charge (Gate-source plus gate-drain)		Qg		_	280	_	
Gate-source charge		Q _{gs}	V _{DD} ≈ 400 V, V _{GS} = 10 V, I _D = 50 A		150	_	nC
Gate-drain ("miller") charge		Q _{gd}			130	_	

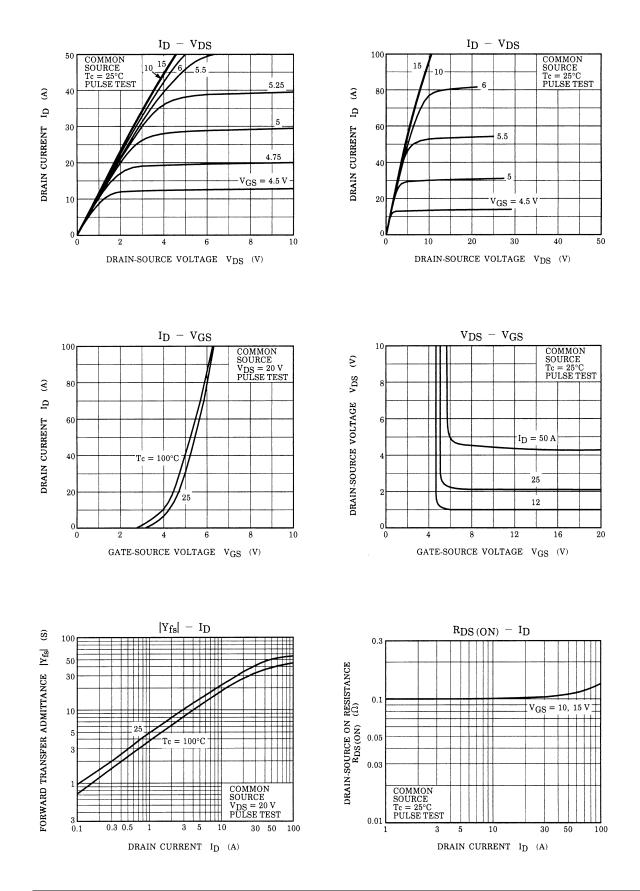
Source–Drain Ratings and Characteristics (Ta = 25°C)

Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Continuous drain reverse current (Note 1)	I _{DR}	—		_	50	А
Pulse drain reverse current (Note 1)	I _{DRP}	_		_	200	А
Forward voltage (diode)	V _{DSF}	V _{DR} = 25 A, V _{GS} = 0 V	_	_	-1.7	V
Reverse recovery time	t _{rr}	I _{DR} = 50 A, V _{GS} = 0 V dI _{DR} / dt = 100 A / μs	1	105	—	ns
Reverse recovery charge	Q _{rr}	dI _{DR} / dt = 100 A / μs		380	—	nC

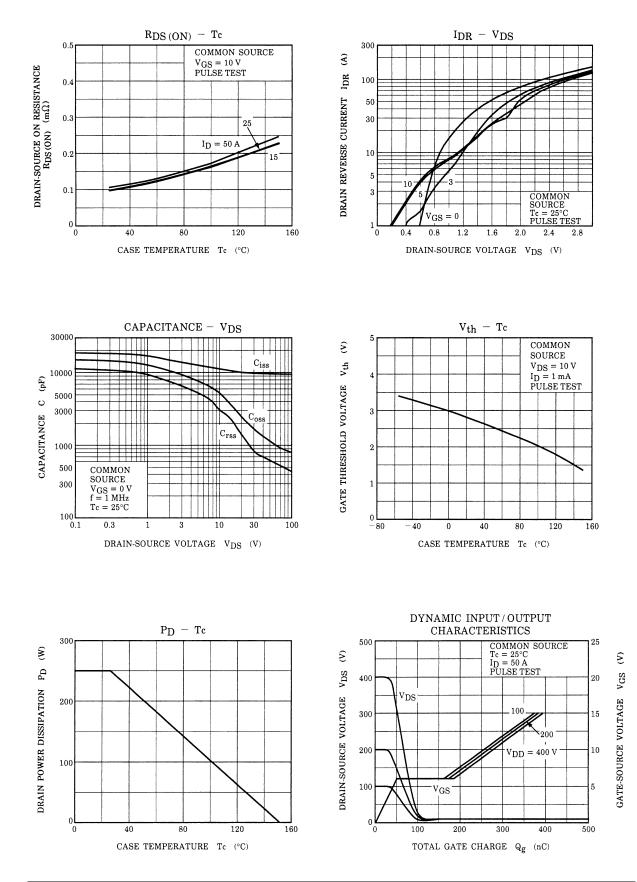
Marking

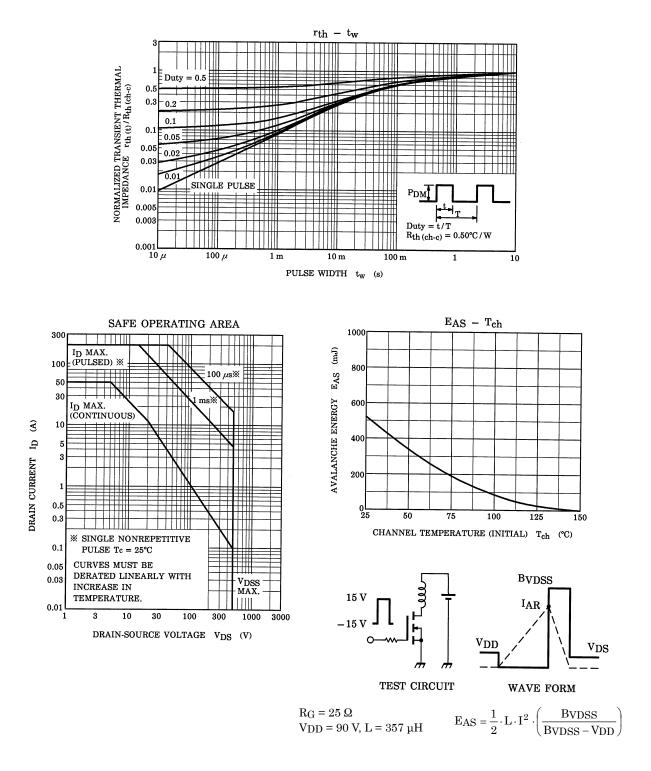


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